

Minutes of Meeting

Product Assurance Space Science and Technology Department

Date: 19-April-2005

NUMBER SPIRE-RAL-MoM- 002408

Subject: PFM1 Cold Verification – Post Test Review

AGENDA:

PTR MoM

- 1. Equipment Description
- 2. Design vs. Build Reconciliation
- 3. Mandatory Inspection Points (MIP) References & Closure
- 4. Review of Actions from Test Readiness Review (TRR) & any Previous Meetings
- 5. Non-Conformances / open Items & Actions
- 6. Test Procedure & Changes since TRR
- 7. Request for Waiver (RFW)
- 8. Hardware Inspection
- 9. Preliminary Summary of Test Results
 - Overview of test campaign
 - Test facility status
 - Functional Tests
 - Instrument Operations
 - Performance Tests
- 10. Any Other relevant Business

Conclusion

Main objectives of the PFM1 cold tests were carried out. Full analysis of test data to be performed.

Meeting Participants

- **RAL:** Dave Smith, Bruce Swinyard, Tanya Lim, Doug Griffin, Sunil Sidher, Samuel Ronayette, Eric Clark, Asier Aramburu
- IC Davide Rizzo

Cardiff: Pete Hargrave, Tim Waskett, Adam Woodcraft, Matt Griffin (part time)

| Written By: | Chaired By: |
|-------------|-------------|
| Dave Smith | Dave Smith |

DISTRIBUTION

Participants + Eric Sawyer, Ken King, Dave Clements(IC), Carsten Schamberg(ESTEC), Didier Ferrand (LAM)



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| Equipment Description | |
|---|--------------------------------|
| Spacecraft / Project | Herschel / SPIRE |
| Instrument / Model | PFM 1 |
| Sub System / Serial No. | N/A |
| As Built Status List of all items /Parts | SPIRE-RAL-DOC-002326 Issue 2.1 |

| Test Documentation | |
|---|---|
| Type of Test | Cold Functional and Performance test |
| AIV Facility Test No. | N/A |
| Location & Date(s) of Testing | SPIRE Calibration Facility 18-Feb-2005 to 15-Apr-2005 |
| Applicable Test Specification (Document No. & Issue) | Test Plan SPIRE-RAL-DOC-2055 issue 1 |
| Applicable Test Procedure (Document No. & Issue) | SPIRE-RAL-PRC-02223 issue 1.0 (formally released at start of test) |
| AIV Facility Test Plan (if applicable?) | NA |
| TRR MoM | SPIRE-RAL-MoM-002306 phase 3 |

| NCRs, Waivers, Open Work | |
|--------------------------|---|
| NCR's | See continuation sheets and appendix 1 |
| Waivers | None |
| Open Work | All open work from TRR closed. |
| Inspection Points | KIP final inspection of FPU, 17/1/05 MIP before closing tank, final TRR 27/1/05 Inspection of FPU to be performed (KIP) |



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CONTINUATION SHEET

Review of Actions:

AI-002306-1 - Pete Hargrave to review the test procedure for PCAL and SCAL, warm functional test - not done.

NCRS

See attachment 1 – NCR spreadsheet

NCRs raised before Test

92.2 N/A for this test 100 open, remedial action taken 101 open, remedial action taken 102 open - no effect on test 103 open - no effect on test 104 open - flight spare unit swapped in - original unit returned 105 open - simultaneous generation BSM & SMEC packets – A update to EEPROM on MCU has been prepared. 106 open - electrical short between FPU and cryostat due to incorrect harness wiring – used as is, did not have significant effect on testing - analysis of noise tests to be done

NCRs raised during test

107 open – dynamic range of SCU thermometers not matched to flight thermometers – fix to SCAL temperature channels to allow tests to continue 108 open – Automatic shutdown of LIAs – to be discussed 109 closed - N/A for this test.

Preliminary Summary of Test Results

Overview of test campaign

Presentation by Dave Smith - Attachment 2

Staffing

Cryostat operations - OK Instrument operations - Worked well with Tim and Davide supporting Sunil and Asier Test directors – Bruce/Tanya – need 3rd person to direct tests – could have Locke, Marc or Pete

Cold tests at ASTRIUM in July AVM tests in Alenia

Test Facility Status

No major problems occurred but some issues need to be resolved before next test campaign.

Some failing thermometers - caused by poor wiring quality - to be investigated.

Thermometer calibrations at instrument I/F - new thermometers needed?

Cold blackbody - cannot get to 4K - may need a further NIR filter - NCR-113

Air leak - possible location identified - propose to seal suspect joint with stycast - NCR114 Pump controller shutting down - NCR-085

Vacuum gauge head failed during pump-down - NCR 111

Laser gas - faulty regulator - NCR 112 - should be checked before each test campaign Could not command TFTS from SCOS – NCR115 – to be investigated before next test campaign.

Calibration curves in SCOS did not match actual thermometers – need to match to serial no.

For PFM2 – QM2 does not have redundant side – hence could read redundant thermometers via lakeshore unit - to be investigated Page 3 of 6



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Functional Tests & Operations

Presentation by Sunil

Action #1 : Safe switch on procedure needs document number - Bruce

Action #2: Test reports for functional tests to be given individual document numbers - Sunil

Problems occurred with simultaneous generation of SMEC and BSM data - an update to the MCU EEPROMs has been generated by Didier

Sequence follows master test procedure – comments added – some changes to be made for PFM2

Power bench needs resetting when MCU is switched on – NCR has been raised – should not be an issue for PFM2 as PSU will be used.

Missing SMEC parameters from HK report – temporary fix implemented

BSM – oscillations in chop and jiggle axes – possibly caused by missing capacitors on QM1 board – NCR-116

JFETs turned on without having to use heaters

PCAL and SCAL tests - plots show resistances as expected

PCAL & SCAL temp vs. current plots - test ok although could be simplified with fewer power steps e.g. low and high

SMEC scans - show expected behaviour

AMV2 DPU did not work with DRCU - separate investigation being conducted

Problems encountered -

LIA shutdown

Action #3: Provide a log of power cycles of JFETs - DS

Anomalous HK parameters for LIA-P and LIA-S at specific bias/sample frequencies – NCR-117 to be raised.

Inability to put SMEC into closed loop at first attempt following SMEC switch on - under investigation

Separate commands are needed to switch on MCU, spectrometer and photometer LIAs - NCR-118

It is easy to send an unknown command to the DRCU - NCR-119

SPR to be raised on TM ingestion in HCSS - can grow to 42,000 - should be investigated before PFM2

QLA frequently 'hangs' - possibly due to amount of memory - should be resolved for PFM2

Should have more people trained in QLA

Lessons to be learned

Avoid unnecessary changes to instrument configuration



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Warm electronics need to be protected - NOTE configuration will be different for next tests Need point of contact for contingency - i.e. difficult to contact

Test scripts need to be rationalised – old test scripts need to be moved off Some effort is needed to write up test sequences as scripts to avoid manual commanding Fault recognition document – need secure folder containing key documents

Action # 4: Compile hard copy folder of critical documents - incl. list of documents , summary sheet - SS/DS

Need a printer Label plugs

Successes

Experience gained from CQM tests enabled problems to be anticipated and solved Sufficient human resources to conduct tests without stress on test team Most tests successfully performed Future tests could be conducted

Plans for future

Test specifications to be updated Creation of HCSS scripts for BSM and SMEC tests Tests with AVM FPU simulator needs updating Update data ICD New version of the OBS which supports autonomy functions

SMEC & BSM Operations

Presentation by Asier

Need written procedures from Didier to tune PID settings Need to analyse SMEC data to understand relationship between power, temperature, settings

Performance Testing

Tanya

Data Test Log, Data Download Status

Excel spreadsheet – to be made available on web site Log complete up to 473 lines – should be complete by end of next week Includes functional tests and operator procedures Data have been downloaded for early tests – remaining will be extracted ASAP

Times in UTC - some discrepancy between actual test times and times recorded in word logs

Additional information for web site pdf'd daily logs, TC history

Web address -> http://scott1.bnsc.rl.ac.uk:8080/hcss/test_area/index.htm

Test Plan

Most tests in plan completed with the following exceptions:

DNC-S noise test with tel sim background DLA-S Beam attenuation using laser CPF-S PCAL loaded frequency characterisation CPN PCAL Flash while nulling OBL/L-S Beam scan using hot BB – type 1 (one was done but not intended) OPI-S Pupil scan using HBB – (done with laser) SRN – room temp nulling – done but failed due to high background SFL – Fringe contrast step and look SML – Mirror carriage characterisation step and look



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OBS – OOB radiation using SMEC

Issues

Need for separate settings for each array Need to search for optimum operating frequency Settings for VMs to be better documented – folder in Q drive – should be in HCSS Unable to do jiggle tests Variable background for BSM tests – most likely due to loading from window More work on pupil scanning – may need test without using actuators - TS not really designed for this test

Changes for next tests

Change noise tests to peakup at each bias Need better SCAL warm up procedure Internal filtering – possibly need more

IDL toolkit – pass tools through Tanya to put on website

Beam Scans

Preliminary plots presented by Samuel For further investigation – look at how beam width varies with wavelength – at least on nominal pixel Peak up maps – measured pixel positions to be compared with optical model

Detector performance

Bruce presented preliminary results Measured spectral resolution is as predicted

Plan for data analysis

Action # 5: Tanya to formalise plan for data processing – who does what and when.

Date of Next Test Campaign

Nominally end of June - Eric to update Schedule

Summary of Actions

Action #1 : Safe switch on procedure needs document number - Bruce

Action #2: Test reports for functional tests to be given individual document numbers - Sunil

Action #3: Provide a log of power cycles of JFETs - DS

Action # 4: Compile hard copy folder of critical documents - incl. list of documents , summary sheet - SS/DS

Action # 5: Tanya to formalise plan for data processing – who does what and when.

| NCR No | No | Level | Title | | | |
|----------------|------|-------|--|--------|--|--|
| HR-SP-RAL-NCR- | 92v2 | Major | SPIRE EQM Electrical Interface Bench Test Anomalies | | | |
| HR-SP-RAL-NCR- | 100 | Minor | amage to PFM SSW BDA J06 and PFM F14 P06 Pin 26 | | | |
| HR-SP-RAL-NCR- | 101 | Minor | Damage to PFM F14 JFS-P12 (Pin 1) | Open | | |
| HR-SP-RAL-NCR- | 102 | Minor | Incorrect labeling of connectors of JFS J11, J12, J13 and J14 | Open | | |
| HR-SP-RAL-NCR- | 103 | Minor | Inconsistent BSM position sensor signal polarity | Open | | |
| HR-SP-RAL-NCR- | 104 | Minor | Ground short on PTC | Open | | |
| HR-SP-RAL-NCR- | 105 | Major | Simultaneous generation of BSM and SMEC frames leads to Frame ID error reports | Open | | |
| HR-SP-RAL-NCR- | 106 | Minor | Electrical short between FPU and Cryostat Chassis | Open | | |
| HR-SP-RAL-NCR- | 107 | Minor | Dynamic range of SCU thermometry not matched to flight thermometers | Open | | |
| HR-SP-RAL-NCR- | 108 | Major | Autonomous Shut Down of LIA's | | | |
| HR-SP-RAL-NCR- | 109 | Minor | Evaporator Straps fail incoming inspection | Closed | | |
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SPIRE PFM1 – Test History



1

Dave Smith

Test History (1)

18-Feb-05 TRR Held • FPU In cryostat **Pump Down Started** 19-Feb-05 • 21-Feb-05 Pump down halted due to fault with vac gauge • Gauge head replaced Pump down restarted 17:00 Short Functional Test performed 22-Feb-05 • 23-Feb-05 Cooldown Started • Cool functional test performed 25-Feb-05 • 27-Feb-05 Started transferring liquid helium • 28-Jan-04 FPU at 4K ٠



Pump-Down





Dave Smith

Cooldown (1)









Dave Smith

Cooldown (2)

FPU Cooldown







Cryogen Use

- Liquid Nitrogen
 - 450 litres for cooldown of LN2 shield
 - <100 litres per day for topping up</p>
 - <200 litres for precooling He Vessels</p>
- Liquid Helium
 - < 750 litres for cooldown</p>
 - 4500 litres used while cold
 - Average 115 litres per day



Test History (2)

- 28-Feb-05 Cold functional tests started
- 01-Mar-05 MCU Tests started
- 03-Mar-05 Tuned SMEC PID settings Cooled L0 temperatures to 1.7K 1st Cooler recycle
- 04-Mar-05 Detectors on Performed dark Load Curves Noise Tests



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Test History (3)

Cooler ran out after >84 hours

• 07-Mar-05

Tests with AVM2 DPU MCU Troubleshooting Attempted Thermal test on cooler pump heater Cooler recycled

Reconfigured with AVM1 DPU
 EEPROMS replaced in MCU to fix noise problem
 Tuned BSM PID settings
 First scans with SMEC on CBB

• 09-Mar-05

08-Mar-05

SMEC scans with laser SCAL 2% tests



Test History (4)

- 10-Mar-05 SCAL 4% tests
 LIAs automatically shut down
- 11-23 Mar-05 Troubleshooting of LIA shutdown
- 24-Mar-05 Detectors back on after JPL go ahead Bias frequency tests CBB nulling with SCAL
- 25-28 Mar-05 Easter break FPU maintained at 4K
- 28-Mar-05 Cryostat back at operating temperatures
 Cooler recycled



Test History (5)

- 29-Mar-05 Beam scans with BSM
- 30-Mar-05 PCAL flash
 BSM chop test
- 31-Mar-05 PTC Tests
- 01-Apr-05 PTC Tests
 Beam scans
- 04-Apr-05
 Upgrade to SCU
 Tests with SCAL at 80K
 Recycled cooler
- 05-Apr-05 Tests with laser at 232µm SMEC scans for SSW Nulling with SCAL-4% at 80K



Dave Smith

Test History (6)

| • | 06-Apr-05 | Tests with laser at 232µm Beam scans Chopper frequency tests Polarisation Pupil scans |
|---|--------------|--|
| • | 07-Apr-05 | Tests with laser lines at 309.5µm and 302.3µm SMEC scans on SSW and SLW Beam scans performed on SSW and SLW Cooler recycled |
| • | 08-Apr-05 | Load curves at different CBB temperatures SMEC scans with laser (530µm) PFM nodding test Performance tests concluded |
| • | 09-14 Apr-05 | Warm Up |
| • | 11-Apr-05 | Functional test of warm electronics performed |
| • | 15-Apr-05 | FPU at Ambient |





Problems/Anomalies

- Vacuum gauge head failed during pump-down NCR-???
- MCU HK acquisition interference on BSM and SMEC control NCR-???
- Limited range of SCU DC thermometer resistance measurement NCR-107
- Possible error in calibration of SCU AC thermometry at high resistance values -
- LIA shutdown NCR-108
- Turbo-pump shutdown NCR-085
- Laser gas faulty regulator





Role of Functional Tests

- To check for basic functionality and integrity of the instrument subsystems.
- To be performed on different models (AVM, CQM, PFM and FS) of the instrument during ground testing.
- To be performed in flight during checkout phase and following instrument and spacecraft contingencies (TBC).
- They are not intended to be used for calibrating or performance testing the instrument.



Functional Test Definitions

All tests are defined in the SPIRE Functional Test Specification document, SPIRE-RAL-DOC-001652 (Issue 1.3 draft, 20th Dec 2004) with principal inputs coming from:

- DRCU/DPU ICD, Sap-SPIRE-Cca-076-02, Issue 1.0, 14th Feb 2003
- MCU/DCU Command List ICD and User Manual, LAM/ELE/SPI/011011, Issue 4.0, 30th Sept. 2004
- SPIRE Data ICD, SPIRE-RAL-PRJ-001078, Issue 2.0, 15th Nov. 2004

Additional reference documents:

- Safe switch on of DCU and connection of JFETs, SPIRE-RAL-NOT-???, Issue 1.0, 22nd Feb. 2005
- JFET switch on procedures for PFM1, SPIRE-RAL-NOT-002285, Issue 1.2, 25th Jan 2005
- MCU QM1 and SMECm CQM test procedure at room temperature, LAM.PJT.SPI.PRC.041020_01 Issue 1, Rev 0, 20th Oct 2004
- SPIRE OBS User Manual, SPIRE-IFS-PRJ-001391, Issue 1.1, 29th Dec 2004



SPIRE EGSE Setup

For the functional tests the SPIRE EGSE was set up and integration tested with the following key components:

- CDMS Simulator version 2.5
- SCOS 2000 2.3e P5 + TOPE
- DPU with OBS version 2.0.A installed
- HCSS v0.2.4 (Build # 572), including EGSE router and gateway
- QLA v2.2.1
- Packet Display Test Tool



Preconditions for Tests

- The Telemetry Ingestion component of the HCSS was running so that all telecommands and telemetry data was stored inside the Versant database of the HCSS.
- Power to the DCU and the SCU was switched on.
- The OBS was running and generating nominal & critical HK telemetry packets.
- QLA was running and the Jython script for the appropriate functional test executing and awaiting test telemetry.
- Functional tests were *generally* performed in the order outlined in the PFM1 Cold Test Master Procedure (SPIRE-RAL-PRC-002223, Issue 1.0).



Warm Functional Tests during PFM1 test campaign - I

| Date | Instrument State | Tests Performed & Principal Anomalies |
|---|---|--|
| 31 st Jan 2005-2 nd Feb 2005 | Cryoharness integrated to warm and cold units. FPU outside cryostat. | SCU – 0.1 mA bias current applied to PCAL, SCAL2 & SCAL4 DCU – but JFETs not switched on MCU – Current limiter needs resetting on Power Bench following switch on BSM – Chop and Jiggle axes step tests SMEC – First attempt to switch on and initialise (Missing SMEC parameters from HK report – SPR on the Data ICD). Temporary fix to HK implemented |
| 15-16 th Feb 2005 | Cryoharness re- integration following fix to the SMEC grounding short problem. Redundant harness for the BSM jiggle axis? SMEC orientation had changed from last time FPU still outside cryostat. | SCU - 0.1 mA bias current applied to PCAL, SCAL2 & SCAL4 DCU – but JFETs not switched on MCU – Current limiter needs resetting on Power Bench following switch on BSM – Chop and Jiggle axes step tests SMEC – Switch on and initialise (Spikes in SMEC science parameters) |



Warm Functional Tests during PFM1 Test Campaign - II

| Date | Instrument State | Tests Performed & Principal Anomalies |
|---------------------------|---|---|
| 22 nd Feb 2005 | FPU inside cryostat. Following pump down. Pump port pressure: 2.63 × 10 ⁻⁵ mbar | SCU - 0.1 mA bias current applied to PCAL, SCAL2 & SCAL4 DCU – but JFETs not switched on MCU – Current limiter needs resetting on Power Bench following switch on BSM – Chop and Jiggle axes step tests SMEC – switch on, initialisation and step tests |
| 25 th Feb 2005 | FPU inside cryostat. Temperature ~ 80K | SCU - 0.1 mA bias current applied to PCAL, SCAL2 & SCAL4 DCU – but JFETs not switched on MCU – Current limiter needs resetting on Power Bench following switch on BSM – Chop and Jiggle axes step tests SMEC – switch on, initialisation and step tests |



Cold Functional Tests during PFM1 Test Campaign - I

| Date | Instrument State | Tests Performed & Principal Anomalies |
|--|-------------------|---|
| 28 th Feb – 3 rd Mar 2005 | SUBKTEMP ~ 3.24 K | SCU - including PCAL, SCAL2 & SCAL4 characterisation tests (SCAL2 and SCAL4 temperatures went out of range at high bias currents) DCU – but JFETs not switched on MCU – Current limiter needs resetting on Power Bench following switch on BSM - Chop and Jiggle axes step tests (Large oscillations in the chop and jiggle axes motor currents and voltages) SMEC – Set up of PID values and performed SMEC Scan Functional Test – SCR on the Data ICD for changes to SMEC science frame Cooler recycled for the first time |
| 4 th Mar 2005 | SUBKTEMP < 300 mK | JFET switch on procedure for PFM1 executed Conclusion: Not necessary to switch on JFET heater |







| 🗙 SCAL | _2 Cur | rent ` | Voltage | e Com | ipar 🗌 | | | 🛛 🗙 SCAL4 Current Voltage Compar 🔤 🗖 🗙 |
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| | | | SCA | L2CURR | | | | SCAL4CURR |









SPIRE PFM1 Post Test Review RAL 19th April 2005 Sunil Sidher





SPIRE PFM1 Post Test Review RAL 19th April 2005 Sunil Sidher











Cold Functional Tests during PFM1 Test Campaign - II

| Date | Instrument State | Tests/Activities Performed & Principal Anomalies |
|----------------------------|-------------------|--|
| 7 th Mar 2005 | SUBKTEMP < 300 mK | AVM2 DPU connected to the WE in place of the AVM1 DPU |
| 8 th Mar 2005 | SUBKTEMP < 300 mK | Reverted back to AVM1 DPU PID tuning for Chop & Jiggle axes |
| 10 th Mar 2005 | SUBKTEMP < 300 mK | LIA switch off problems MS Word problems in keeping Test Logs |
| 4 th April 2005 | SUBKTEMP ~ 1.8 K | Resistors for SCAL2 and SCAL4 replaced on SCU board for nulling tests with the CBB |



Warm Functional Tests after Warm Up

| Date | Instrument State | Tests Performed & Principal Anomalies |
|-----------------------------|--|---------------------------------------|
| 11 th April 2005 | Test on the stand alone Warm Electronics in the Control Room, without an MCU. | DCU SCU |



Problems Encountered - I

- Spontaneous switching off of the LIAs appears to be related to the LIA temperatures.
- Anomalous HK parameter values for the LIA-P and LIA-S temperatures and voltages at specific bias and sampling frequencies. An NCR needs to be raised - but is it on OBS or DRCU?
- Inability to put the SMEC into closed loop at first attempt following SMEC switch on and initialisation. Subsequent attempts are invariably successful. Under investigation by Asier with Didier at LAM.
- It is critical to have separate DRCU commands to switch on the MCU, Spectrometer and Photometer LIAs. The potential for accidentally switching on or switching off a subsystem is enormous, despite safeguards in scripts. Raise an NCR?
- It is quite easy to send an unknown command to the DRCU. The DCU, MCU or SCU should reject a command which is not listed in the ICD. Or is it an OBS task to reject such commands?


Problems Encountered - II

- The time on the CDMS Simulator drifts by ~ 30 seconds in 24 hours. SPR already open but needs addressing with high priority.
- TFCS cryostat temperature sensors were changed before the campaign which caused confusion during monitoring with SCOS.



SCOS Problems during Tests

- SCOS 2000 History File Archive (HFA) was found to be ingesting science TM as well as HK and Event Reports. This problem became apparent just in time and the EGSE gateway was reconfigured to prevent serious consequences.
- A fundamental limitation of the HFA under SCOS 2.3eP5 is that it can grow to a maximum of before a new HFA needs to be set up. The archive splitting tool only works under SCOS 3.1, which is still awaiting the addition of EGSE extensions at ESTEC.
- Occasionally some of the SCOS and EGSE tasks, such as Telecommand History, TOPE and PDSTC, disappear without warning. Usually they can be restarted but can cause delays during testing.



HCSS Problems

• The CUS lacked functionality to return the size of a calibration table stored inside the HCSS database. A workaround using TCL was developed but it required the table to be present on the SCOS machine.

An SCR has been raised on the CUS.

 Size of the TM ingestion store queue needed to be monitored regularly. It grew to a maximum of ~ 42,000 items while Spectrometer bolometer array and SMEC science data were being generated at 53 and 250 Hz respectively during a beam scan observation. The PFM1 database was safeguarded against loss of data and/or corruption by the stopping of non-essential data generation. An SPR needs to be raised – on TM ingestion or Versant DB?



QLA Problems

- QLA scripts for some functional tests need to be refined to provide a more clear Pass/Fail criteria. Specific examples include
 - Comparison of SCU parameter values in HK and science frames
 - Comparison of latest DCU, MCU and SCU test patterns with previous test patterns
 - Comparison of BSM parameter values in HK and science frames
- QLA frequently hangs, leading to much confusion about the status of tests and data generation interim solution was put in place during testing but needs further investigation.
- More people need to be fully trained in running QLA.



Lessons Learned

- Never change the configuration of the instrument during testing unless absolutely necessary to continue with the tests, otherwise more free parameters are introduced into an already complex system. The problems with the AVM2 DPU will be investigated with SPIRE AVM.
- SPIRE Warm Electronics (WE) power bench continued to cause problems at switch on of the LIAs or the MCU. The protection screen in front of trolley was a source of hindrance to the test team.
- Lack of space in the Cryo Lab leaves no margin for error. Potential for accidental switch on or switch off of critical test equipment cannot be overlooked.
- To avoid long delays during a test campaign a point-of contact must be established at each participating institute for the reporting of subsystem problems which need urgent attention.



Successes

- Experience gained from CQM campaigns allowed us to anticipate and solve potential problems.
- In this campaign we had enough human resources to conduct the tests without the test team suffering from fatigue.
- Most tests were successfully performed.
- Future campaigns could in principle be conducted with a subset of the PFM1 test team.



Plans for the Future

- The Functional Test Specification needs to be updated
- Creation of HCSS scripts for the BSM and SMEC tests
- Tests with the AVM to commence
- Plans for the FPU simulator?
- Update Data ICD
- New version of the OBS which supports Autonomy Functions



Contents

Test Log, Data Download Status

Test Plan

- DETECTOR TESTS
- PCAL TESTS
- OPTICAL TESTS
- BSM CHARACTERISATION
- SPECTROMETER SPECIFIC TESTS
- SCAL TESTS

Data Analysis Responsibilities



Test Log/Website Status

- Baseline log complete up to April 5th
 - Without last day 473 lines on the spreadsheet (about 450 tests logged)
- Website a few days behind
- Aiming to complete baseline log either this week or next week
- Final log may take more time
- · Data so far downloaded for early tests and priority cases only
- Remaining data ASAP but may take a few weeks

Longer Term

- Tidy up logs from previous campaigns
- Would like to add other data e.g. from beam monitor
- What about Word logs and uplink logs?



DETECTOR TESTS

- 1. DNA-S Noise Test with Lowest Possible Background ${\cal N}$
 - Done at 160Hz, 70Hz, 106Hz (5 mins)
 - Overnight noise for three nights
- 2. DNC-S Noise Test with Telescope Representative Background X
 - Not done but room data and CBB data can be used
- 3. DAB-S Dark Load Curves $\sqrt{}$
 - Done at 70 Hz and 160 Hz
 - Shorter version introduced and done following cooler recycles
 - Did load curves with LED on and off
- 4. DAL-S Optical Load Curves $\sqrt{}$
 - Done at 70 Hz, 7.5 K, 10 K, 15 K
 - Done at 160 Hz, 7.5 K
- 5. DRB/L-S Time Response With The Hot Black Body or Laser $\sqrt{}$
 - Done for two pixels SSW D1,D3
- 6. DLA-S Beam Attenuation Using The Laser X

SPIRE PFM1 Test Review



PCAL TESTS

- 1. CPT-S PCAL Dark Frequency Characterisation $\sqrt{}$
 - Done internally only
- 2. CPF-S PCAL Loaded Frequency Characterisation X
 - Not Done
- 3. CPN Flash While Nulling X
 - Not Done
- 4. CPS-S PCAL Standard Flash $\sqrt{}$
 - Done at least 4 times
- 5. Added Test to flash PCAL at various SMEC positions ${\cal N}$
 - Done



SCAL TESTS

- 1. CSC Spectrometer Calibrator Load Curves $\sqrt{}$
 - Done separately for SCAL 2 and SCAL 4
 - SCAL 2 0.22, 0.45, 0.70 mA
 - SCAL4 0.22, 0.75 mA
- 2. CSL SMEC Low Resolution Scan With SCAL On $\sqrt{}$
 - Done LR scans for SCAL2, HR for SCAL4, LR while heating up
- 3. CSS Scanning the SMEC While SCAL is Cooling X
 - Not Done but used CSL as an alternative test



OPTICAL TESTS

- 1. Focus Test $\sqrt{}$
 - Done both using 'X' raster and '+' raster, on central pixels
- 2. PKB/L-S Peak-Up Using T/S With The Hot Blackbody or Laser $\sqrt{}$
 - SLW pixels, A1,A3,B2,B3,C1,C2,C3,C4,C5,D2,D3,E1
 - SSW pixels, B3,C2,D4,E2
- 3. PKI-S Peak-Up Using The BSM With The Hot Blackbody or Laser $\sqrt{}$
 - Not done as a jiggle map as intended
- 4. OSB/L-S Beam Scan Using The T/S With The Hot Blackbody or Laser Type 1 X
 - Not done but not intended
- 5. OSB/L-S Beam Scan Using The T/S With The Hot Blackbody or Laser Type 2 $\sqrt{}$
 - Done
- 6. OSB/L-S Beam Scan Using The T/S With The Hot Blackbody or Laser Type 3 $\sqrt{}$
 - Done only as part of focus test on D4

OPTICAL TESTS (Continued)

- 1. OPI-S Pupil Scan Using Hot Black Body X
 - Not done with BB used laser
- 2. OPI-S Manual pupil scan using Laser $\sqrt{}$
 - Done
- 3. OPI-S Pupil Scan using actuators $\sqrt{}$
 - Done but failed
- 4. OBL-S Out of Band Rejection Using OOB Laser Lines $\sqrt{}$
 - Done
- 5. DPB-S Polarisation With The Black Body or Laser $\sqrt{}$
 - Done SSW D1, D4



BSM CHARACTERISATION

- 1. BSM-S BSM Characterisation $\sqrt{}$
 - Done by stepping chopped blackbody signal
 - Also moved between two pixels using external chopper
- 2. BCT-S BSM Chop Throw $\sqrt{}$
 - Done between all chop axis pixels, both arrays, not done off axis
- 3. OPB-S Beam Scan Using The BSM $\sqrt{}$
 - Done for SLW C3
- 4. Operations Test Simulated Nodding $\sqrt{}$



SPECTROMETER SPECIFIC TESTS

- 1. SSC Spectral Scan With Cold Black Body Un-nulled $\sqrt{}$
 - Done
- 2. OBP Balancing of Ports (Nulling Test) $\sqrt{}$
 - Done
- 3. SRN Room Temperature Nulling
 - Done but Failed
- 4. SFC Fringe Contrast and Spectral Response While Scanning $\sqrt{}$
 - Done for SLW C3, B2, SSW
- 5. SFL Fringe Contrast and Spectral Response Step and Look X
 - Not Done
- 6. SMC Mirror Carriage Characterisation While Scanning $\sqrt{}$
 - Done
- 7. SML Mirror Carriage Characterisation Step and Look X
 - Not Done
- 8. OBS Out of Band Radiation Using the SMEC X
 - Not Done



Summary I

- Not Done
 - Beam Attenuation
 - PCAL loaded frequency characterisation, PCAL while nulling
 - Step and look tests
 - Some tests only partially done e.g. SCAL tests, optical tests open ended
- New tests
 - Flashing PCAL at different SMEC positions
 - Shorter version of dark load curve for after cooler recycle
- Changes
 - BSM tests pretty much defined as we went along as expected



Summary - II

Issues

- Need for separate array detector settings not communicated effectively
- Half SSW detectors very noisy needed to search for best operating frequency – impacted test scripts
- Settings for VMs need to be better documented
- Unable to do jiggle tests
- Very variable background for BSM tests
- More work needed on pupil test?
- Changes for next tests
 - Change noise tests to peakup at each bias
 - Need better SCAL warm up procedure
 - Internal filtering Room nulling, BSM background

SPIRE

Data Analysis

Detector Data

Noise Tests – Tanya

Load Curves – Adam, Bruce, Bernhard

Time Response – Sarah (as beam attenuation not done)

<u>Calibrator Data</u> All Data – Cardiff (overlap with the load curves)

Optical Data

Focus, Peakups, T/S Beam Scans – Samuel (Tanya) and Mark

Polarisation, OOB – Sarah or Imperial

BSM Data

Performance Tests – Tanya

Simulated Nodding – Imperial

Spectrometer Tests All Data - Leithbridge, LAM, Bruce

- BSM operation:
- Major issues:
 - Zero target position different from zero current position. (optical misalignment?)
 - Is the conversion between ADC sensor value and position in the sky dependant on the gain of the electronics used? (probably yes)
 - Discrepancy between initial PID parameter tuning and "real" performance. (slow response).
 - PID parameters had to be retuned when chopping between pixels was performed.

More major issues:

- Are the PID parameters dependent on the electronics?
- Is the BSM "square test pattern" different from a real chopping between pixels?
- If not, why did we have to change the close loop settings.

For next test campaign:

Need to understand better the PID parameter tuning process.

- SMECm operation:
- Major issues:
 - SMEC initialisation procedure failure.
 - Is this a software problem or a mechanical problem?
 - Need to revise switch on and switch off procedures.
 - Need a repeatable reliable sequence for initialisation ,completely automatic and "blind".

More major issues:

 If the encoder sine signals levels are strongly dependent on the thermal situation ,how can we overcome this?

• For next test campaign:

- Improved initialisation procedure.

- General remarks:
 - The functional check procedures need to be revised by the relevant people.
 - for example BSM open loop step setting was only done properly after Didier was at RAL.
 - No one had taken a look at the functional test document to verify for the real utility of some of the fucntinal tests.





peak up at 45 deg with HBB



peak up with LASER – $302 \mu m + 309 \mu m$

 $beam\ scan\ SSW/B3-302 \mu m$



Beam scan SLW/C4 – $302 \mu m$



Pixel centres





Background power looking into room (pW) from loadcurves



Note swapped pixels:

DP2 is in the G3 position F5 is in the G4 position F4 is definitely a dark pixel F4 and F5 positions show no response.

D5, D6 and D7 don't seem to work very well

PFM1 Post Test Review

Interferogram with laser on SLW



19 April 2005

PFM1 Post Test Review

Interferogram with laser on SLW – fitting cosine for 432.631 micron



19 April 2005

PFM1 Post Test Review
Phase variation linear with OPD – subtracted cosine in spectral space



PFM1 Post Test Review

19 April 2005

B2 with line compared to C3 without – and position error spectrum



PFM1 Post Test Review

Line in spectral domain with and without apodisation



19 April 2005

PFM1 Post Test Review

Resolution

- The recovered line profile with no apodisation the FWHM is about 0.89 mm giving a resolving power of R~483.
- The scan length from ZPD was about 3.2 cm giving an expected resolution of 1.22/(2.0*3.2*4.0) = 0.0476 cm-1 – or R~485 at this wavelength.
- Seems to be some phasing problem across base of line pedestal not even either side of line needs further investigation.
- Spectrometer seems to be working for "high" resolution despite the horrible microvibration environment and possible ghosting.
- Next jobs look at other pixels; look at other wavelengths; look more closely at phase errors versus SMEC position.

SLW C3 on the room



19 April 2005

PFM1 Post Test Review